

**Search Notes****Application/Control No.**

10/728,135

**Examiner**

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**Applicant(s)/Patent under Reexamination**

CHANG ET AL.

**Art Unit**

1795

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference-see updated search history print out		1/30/2008	DCD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(430/322, 320) updated text search only-see updated search history print out	1/30/2008	DCD
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB)-see search history print out	1/31/2008	DCD
Updated search history print out	1/31/2008	DCD
eDAN inventor search performed	1/30/2008	DCD